•	Searc	n No	ites	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,098	AVIDOR ET AL.	
Examiner	Art Unit	
David Q. Nguyen	2681	

	SEAR	CHED	·· <del>·</del>	
Class	Subclass	Date	Examiner	
405	25°	06/05/05	an a	
	400			
	561			
400 400	3U			
סנית	2409	66/n 06		
	( ,		0,	
Unl	eti sa	.l rel	2g/cc	07
- Space	M XE	em Uff.	19/40	
<del></del>	<del></del>			
	*****			

rni	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text search	u) du	n		